

ULTRAFAST SPEED & HIGH PERFORMANCE DUAL-SIDE FLYING PROBE TESTER

APT-1600FD Series



The APT-1600FD Series is a dual-sided flying probe test system that deploys the flying probes to both sides of a UUT. Owing to the dual-sided probing contact, the APT-1600FD Series can contribute to a marked increase in test coverage and also assures the shortest amount of test time.

In addition, the APT-1600FD Series has world-level advantages in test speed and positioning accuracy and is equipped with a wealth of extraordinary test functionalities, so that your SMT boards can be tested with ease and precision in a short amount of time.

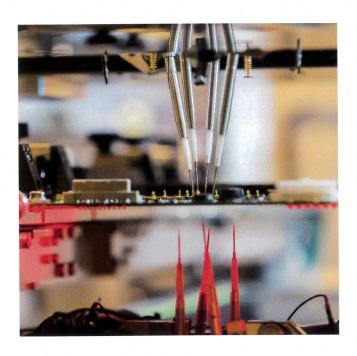
FLYING PROBE TESTER APT-1600FD Series

SAFE AND HIGHLY ACCURATE MEASUREMENT SYSTEM

The APT-1600FD series incorporates 16-bit DC 4-quadrant sources & measurement system and AC programmable generator which is also finding uses as a function generator in the measuring unit so that the tester is capable of applying the best-suited measuring signals according to the specification of each electronic component and the circuit conditions and realizes the circuit test and dynamic characteristics test. Also, the dedicated measuring mode for very small capacitance and the high measuring accuracy circuit give aid to detect a wide range of assembly faults.

ULTRAFAST TEST SPEED!!

The high power & fast-moving rotary motor system, which has superior performance in practical moving distance, and the new high-speed communication control contribute to speed up test $30 \sim 50\%$ faster than the conventional models. Also, combination tests performed by using the flying probes on the bottom side make the test time even shorter.

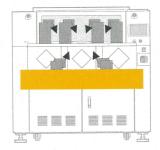


ATTENUATING CONTACT PRESSURE OF PROBES

The APT-1600FD series has outstanding ability in controlling the probing speed just before it contacts. This enables to minimize the probing marks on small and sensitive test lands without compromising on test speed.

BREAKTHROUGH 4-HEADS & 6-FLYING PROBES ON TOP, 2-HEADS & 4-FLYING PROBES ON BOTTOM

In addition to the standard moving probes which are installed diagonally to the UUT, vertical Z-axis units (option) where either probe or IC-open test probe can move up and down vertically are also available on both top side and bottom side. The vertical Z-axis units enable to get access to the test points where are hard for the standard flying probes. Besides, it's possible to directly contact the through-holes and the head of connector pins by using different types of probes, resulting in increased test coverage.



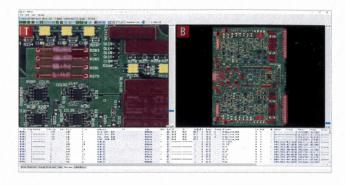
HIGH ACCURACY ENSURED BY RIGID XY STAGE

The tester's XY stage, crucial to stable and accurate probe contact, is made of highly polished native granite, as well as the APT-9xxx series which is thought of as the global standard model of the flying probe testers. Also, the positioning accuracy is finely tuned tester by tester. Therefore, the APT-1600FD series ensures superfast probe movement and increased positioning accuracy by 25% compared to the conventional models.

TEST ABILITY IN A CONSTANT STATE OF EVOLUTION The APT-1600FD series serves its customers with versatile option boards and software that achieves their particular needs, such as the LED color test system that measures hue, saturation and luminance of LED devices on the board under test, the component height test based on laser ranging, the Boundary testing, and the Functional testing. Also, the tester will have even more advantages to enhance its test coverage and speed up test although they are currently under development. INDUSTRY 4.0

COLORED VISION SYSTEM AND REAL MAP

The APT-1600FD series is equipped with new vision test system TOS-7F corresponding to color images as standard on both top and bottom side. Owing to the megapixel color digital camera and the ring illuminations with high-intensity white LED, the TOS-7F can import sharp color image to detect missing, wrong orientation and positioning error on the spot. Besides, the TOS-7F can not only read the barcodes (including 2D codes) but also offer color identification test and Library function which are supported by the optional software. Also, the APT-1600FD series is equipped with the colored Real map function which is of remarkable help to check and modify the contact points during debugging the programs.



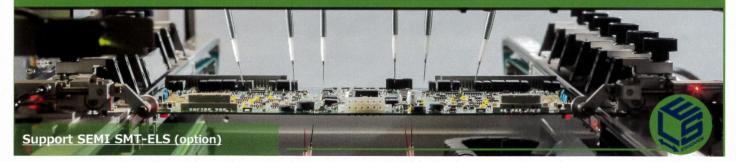
LARGER TEST AREA & AUTO TRANSFER

The "-SL" series, which provides 48% larger test area, and the "-A" series, which enables to transfer UUT automatically, are also available for selection to fit user needs.

Stan	Large size (-SL series)		
OFFLINE model	INLINE model (-A series)	OFFLINE model	
Test area L540 x D483mm	Test area L540 x D483mm	Test area L635 x D610mm	
W1400 x D1500 x H1400mm 1450kg	W1400 x D1500 x H1400mm 1450kg	W1520 x D1620 x H1400mm 1600kg	
APT-1600FD	APT-1600FD-A	APT-1600FD-SL	

AUTOMATED CONVEYOR SYSTEM

An automated conveyor system model can be built-to-order to establish a fully automated operation in your production line or rack-to-rack system. To meet various user's needs, it's possible to provide a buffer station with conveyor installed to cut down transport time as much as possible and an auto-conveyor width adjustment unit, as well as a shutter unit that operates when the conveyor carries a PCB in and out.



Board specifications

	APT-1600FD	APT-1600FD-A	APT-1600FD-SL
Board size	L50 x D50mm to L540 x D483mm L50 x D50mm to L635 x D610mm		
Board Thickness	0.6mm to 5.0mm		
Component height (max.)		Top side 60mm	
		Bottom side 60mm including board thickness	
Component-free area	3mm or more from front and rear edges (for board clamp)		
Board weight (max.)	5kg	3kg	8kg

Automated conveyor specifications (Inline model only)

Automateu conveyor	specifications (Tilline model only)		
Transfer speed and belt	200 to 667mm/sec. (6 ranges)		
(Speed selectable)	Timing belt (anti-static type)		
• Transfer direction / height	Direction selectable, FL 900mm (-15/+65mm)		
 Conveyor width adjustment 	Front side - fixed, Rear side - auto-adjustment with correction mechanism of parallelism		

Specifications

Speed	& accuracy	y
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		APT-1600FD /	APT-1600FD-A	APT-1600FD-SL	
Test time (at 2.5mm pitch mo	ovement)	Combination test : Max	c. 0.02 - 0.03sec. / step	Combination test: Max. 0.03 - 0.04sec. / step	
(at Elemin plant more ment)		Single test : Max. 0	.05 - 0.06sec. / step	Single test: Max. 0.07 - 0.08sec. / step	
 Positioning repeatability of flying probe (XY) 		±25 to ±40µm in the high	n precision mode, approx.	± 30 to $\pm 40 \mu m$ in the high precision mode, approx.	
Minimum pad size for flying probes		60 to 80µm in the high	precision mode, approx.	80 to 100µm in the high precision mode, approx.	
General (all models)					
• Flying probes and sensors Top side Bottom side	Top side	Standard type	: 4 tilted contact probes		
		Standard with single vertical Z type	e : 4 tilted contact probes, 2 vertical contact probes or 2 IC-open test probes (changeable)		
		Standard with dual vertical Z type	: 4 tilted contact probes, 2 vertical co	ontact probes, 2 IC-open test probes	
		LED color test sensors	: 2 sensors (option)		
	Bottom side	Standard type	: 2 tilted contact probes		
		Standard with single vertical Z type	: 2 tilted contact probes, 2 vertical co	ntact probes or 2 IC-open test probes (changeable)	
		LED color test sensors	: 2 sensors (option)		
 Specifications of contact probes 	s	Type : High precision spring probe, Cu	rrent rating : 2A, Tip form : Needle, sm	nall 4-crown, etc.	
 Motors system for flying probes (XYZ axes) 		High speed AC servo motors & control s	ystem		
 Positioning resolution of flying probes 		X and Y axes: 1.25µm Z axis: 5µm			
Minimum pad pitch for flying p	robes	150 to 190µm in use of needle probes (high precision mode)			
Test (all models)					
 Signal sources for board test 		DC Voltage / Current generator -1	: Four-quadrant source & measure system, max. ±20V/±1A ^(*1)		
		DC Voltage / Current generator -2	: Four-quadrant source & measure system, max. ±20V/±1A ^(*1)		
		DC Voltage / Current generator -3	nerator -3 : Four-quadrant source & measure system, max. ±80V/±1A (option)		
		AC Constant Voltage generator	: max. 20Vpk / 100mApk, f=1Hz to 0.5MHz (sine, square or triangle wave)		
Measuring range		DC Voltage, Current	: ±125V, ±1A ^(*1) (max.±40V) c	or ±1A (max. ±80V, option)	
		AC Voltage	: 150mV to 75Vrms, f = 10Hz to	0.5MHz	
		Frequency	: 1Hz to 20MHz / 2V to 20Vp-p		
		Resistors	: $5m\Omega$ to $50M\Omega$		
		Capacitors	: 0.5pF to 200mF		
		Inductors	: 0.5µH to 500H		
		Impedance / phase angle	: 2.5Ω to 3.3MΩ / ±90°		
		Transformers	: Inductance, detection of windin	ng, transmission ratio	
		Forward voltage of PN junction	: 0.1V to 40V		
		Zener voltage	: 0.1V to 40V (max.80V, option)		
		Isolation test	: Threshold is programmable from 5Ω to $50M\Omega$		
		Continuity test	: Threshold is programmable from 1Ω to $500 \text{K}\Omega$		
		Diodes / Transistors / FETs	: Forward voltage of PN junction, ON test, Gain, Static characteristics		
		Relays / Opti couplers / SW devices	: ON test		
		Open fault detection of IC leads	: Forward voltage measure of PN	Junction, or IC-open test probes	
		Lighting color of LED (option)		measured by LED color test sensor	
Judgment tolerance set		-999.9% to +999.9% or absolute value			
Test steps		Max. 350,000 steps			

Vision test system TOS-7F (all models)

Video camera
 Light source
 Ring-shaped white LED with 256 levels of brightness adjustable

Application
 Coordinates alignment, simple vision test, reading of barcode & 2D code, color real-map, etc.

Vision test item
 Non-mounted components, components shifting, missing components, polarity, color inspection of parts, etc.

Image registration
 Max. 2,000 scenes (top and bottom total)

Laser Displacement measurement system TLS-1

Light source Red semiconductor laser (top side)

 Measurement method Light / reflective type (laser displacement)

Laser beam diameter
 0.25 x 2.65mm to 0.40 x 2.75mm (changes by the height of the measurement point)

Measuring range
 Repeatability
 −0.5mm to + 50.0mm
 ±100µm or less

Application Coordinates alignment by automatic generation of 3D-mapping
 Non-mounted components, floating components, missing component, etc.

Usage environment (all models)

 Embedded PC & OS
 Windows® PC (with DVD drive, HD drive, keyboard, mouse)
 OS : Windows 10

 Display & Printer
 LCD : 1920 × 1080 resolution
 Printer : Small thermal type (USB connection)

 Power & Air supply
 Power : AC200 to 240V(single phase), 50/60Hz, max. 4.0KVA
 Air : 0.6 to 0.8Mpa (dry clean air)

 Operating environment
 Temperature : 16 to 30°C (60 to 86°F)
 Humidity : 30 to 75% (no condensation)
 Altitude : Below 1000m

Options

• Laser displacement measurement system for bottom side • LED color test system • DC ±80V/±1A programmable source & measurement unit • Function scanner board • Power relay board • Marking unit • Vacuum Unit • CMD Line execution function • NSW test function, etc.

- *1 The maximum current can be increased to 2A by using function scanner board (option).
- st The technology and the options under development are included in specifications as of January, 2021.
- * Specifications are subject to change without any obligation on the part of the manufacturer.



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